

Issue Classification				Application/Control No. 10/572,702				Applicant(s)/Patent under Reexamination FUTAMI, TOSHIHIKO			
				Examiner Tran N. Nguyen				Art Unit 2834			

ISSUE CLASSIFICATION															
ORIGINAL				INTERNATIONAL CLASSIFICATION											
CLASS		SUBCLASS		CLAIMED				NON-CLAIMED							
310		156.48		H	02	K	1	/27				/			
CROSS REFERENCES								H	02	K	1	/24			/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							H	02	K	1	/22			/
310	156.53	156.54	156.56	156.57	H	02	K	21	/14				/		
					H	02	K	21	/16				/		
									/				/		
									/				/		
												Total Claims Allowed: 6			
*** (Assistant Examiner) (Date)				Tran Nguyen (Primary Examiner) 4/14/07 (Date)				O.G. Print Claim(s) 1				O.G. Print Fig. 1, 3			

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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